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FOR USE	D AGENC	DEF	PART OF T	MEN HE	rs	28	Sep	G APF	er						SIZE			40				8	34	0	94	4
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1. SCOPE						
1.1 Scope. This drawing describes dev with 1.2.1 of MIL-STD-883, "Provisions fo non-JAN devices".	ice requirement r the use of M	ts for clas B mi IL-STD-883 in co	crocircuits in accordance njunction with compliant			
1.2 Part number. The complete part nu	mber shall be	as shown in the	following example:			
84094 01		E T I	X T			
Drawing number Device (1.2.		Case outline (1.2.2)	Lead finish per MIL-M-38510			
1.2.1 Device type. The device type sho	all identify t	he circuit funct	ion as follows:			
Device type Generic nu	mber	Circuit	function			
01 54HC16	2	4-bit synchronous res	us BCD counter with et			
1.2.2 <u>Case outlines</u> . The case outlines shall be as designated in appendix C of MIL-M-38510, and is follows:						
Outline letter		Case out	<u>line</u>			
E F 2	F-5 (16-Tead	, 1/4" x 3/8"),	dual-in-line package flat package 50"), square chip carrier			
1.3 Absolute maximum ratings. 1/						
Supply voltage range	onds)					
1.4 Recommended operating conditions.						
Supply voltage		55°C to +:	125°C s			
V _{CC} = 6.0 V		- 0 to 400 n				
1/ Unless otherwise specified, all voltages are referenced to ground. Z/ For T_{C} = +100°C to +125°C, derate lineraly at 12 mW/°C.						
STANDARDIZED	SIZE					
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Minimum recovery time, clear to clock (t<sub>RFC</sub>) 3/:
  at 25°C
   V<sub>CC</sub> = 2.0 V - - - - - - - - - - - - - - - -
                                         125 ns
   25 ns
  V_{CC} = 6.0 \text{ V} - - -
at -55°C to +125°C
   Včč = 6.0 V - - - - - - - - - - - - - - -
                                          32 ns
Minimum setup time, load, clear or data, to clock (t_s) 3/:
  at 25°C
   V<sub>CC</sub> = 2.0 V - - - - - - - - - - - - - - - - - -
   V<sub>CC</sub> = 6.0 V - - - - - - - - - - - - - - - - - at -55°C to +125°C
                                          26 ns
   225 ns
                                          45 ns
                                          38 ns
Minimum setup time, enable to clock (t_S): at 25°C
   V<sub>CC</sub> = 2.0 V - - - - - - - - - - - - - -
  35 ns
   VCC = 6.0 V - - - - - - - - - -
                                          44 ns
Minimum pulse width, load, clear or clock (t_W) 3/:
   V<sub>CC</sub> = 2.0 V - - - - - - - - - - - - - - -
                                         100 ns
  17 ns
                                         150 ns
                                          30 ns
   VCC = 6.0 V - - - - - - - - - - - - - - -
                                          26 ns
Minimum hold time, data from clock (tH) 3/:
  at 25°C
  50 ns
                                           9 ns
   75 ns
                                          15 ns
   VCC = 6.0 V - - - - - - - - - - - - - - - -
Minimum hold time, enable, load, or clear from clock (ty):
   25 ns
   VCC = 6.0 V - - - - - - - - - - - - - - at -55°C to +125°C
                                           5 ns
   VCC = 2.0 V - - - -
                                          40 ns
   VCC = 4.5 V - - - - - - - - - - - - - -
   VCC = 6.0 V - - - - - - - - - - - - - - -
See footnote on next page.
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2. APPLICABLE DOCUMENTS

2.1 Government specification and standard. Unless otherwise specified, the following specification and standard, of the issue listed in that issue of the Department of Defense Index of Specifications and Standards specified in the solicitation, form a part of this drawing to the extent specified herein.

SPECIFICATION

MILITARY

MIL-M-38510

- Microcircuits, General Specification for

STANDARD

MILITARY

MIL-STD-883

- Test Methods and Procedures for Microelectronics.

(Copies of the specification and standard required by manufacturers in connection with specific acquisition functions should be obtained from the contracting activity or as directed by the contracting activity.)

- 2.2 Order of precedence. In the event of a conflict between the text of this drawing and the references cited herein, the text of this drawing shall take precedence.
 - 3. REQUIREMENTS
- 3.1 Item requirements. The individual item requirements shall be in accordance with 1.2.1 of MIL-STD-883, "Provisions for the use of MIL-STD-883 in conjunction with compliant non-JAN devices" and as specified herein.
- $3.2\,$ Design, construction, and physical dimensions. The design, construction, and physical dimensions shall be as specified in MIL-M-38510 and herein.
 - 3.2.1 Terminal connections. The terminal connections shall be as specified on figure 1.
- 3.2.2 Truth table and logic diagram. The truth table and logic diagram shall be as specified on figure 2.
 - 3.2.3 Case outlines. The case outlines shall be in accordance with 1.2.2 herein.
- 3.3 Electrical performance characteristics. Unless otherwise specified, the electrical performance characteristics are as specified in table I and apply over the full case operating temperature range.

3/ See figure 3.

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Т	ABLE I.	Electrical performa	nce characteristi	cs.			
Test	 Symbol	Condition -55°C < T _C < unless otherwi		 Group A subgroups	Limits		 Unit
High-level output voltage	 Vo::		se specified VCC = 2.0 V	1	 1.9		 V
mign-rever output vortage	1 011	$ V_{IN} = V_{IH} \text{ or } V_{IL}$ $ I_0 \leq 20 \mu \text{A}$	IV _{CC} = 4.5 V	1	4.4	 	i T
	İ		V _{CC} = 6.0 V	1	5.9	<u> </u>	
	 	 I ₀ <u><</u> 4.0 mA	V _{CC} = 4.5 V	 	3.7	 	
	 	I ₀ < 5.2 mA	V _{CC} = 6.0 V	† -	5.2		Ť I I
Low-level output voltage	VOL	 V _{IN} = V _{IH} or V _{IL} I _O < 20 µA	V _{CC} = 2.0 V	1,2,3		0.1	V
	İ	1	V _{CC} = 4.5 V	† - 	i I	10.1	Ť I
	!	1	V _{CC} = 6.0 V	T [0.1	Ť <u>I</u>
	! 	 I ₀ <u><</u> 4.0 mA	V _{CC} = 4.5 V	T 	 	0.4	[<u> </u>
		 I0 <u><</u> 5.2 mA	V _{CC} = 6.0 V	· 	 	0.4	
High-level input voltage 2/	AIH		V _{CC} = 2.0 V		1.5		٧
-	!	1	V _{CC} = 4.5 V	1	3.15	· ·	T I
	<u> </u>		V _{CC} = 6.0 V	<u> </u>	4.2		[
Low-level input voltage 2/	VIL		V _{CC} = 2.0 V	1,2,3] 	0.3	V
	!	l I	V _{CC} = 4.5 V		<u> </u>	0.9 	<u>[</u>
	<u> </u>		V _{CC} = 6.0 V			11.2	
Input capacitance	CIN	 V _{IN} = 0 V, T _C = +25 See 4.3.1c	°C	4	 	10	l pF
See footnotes at end of tab	le.			•			
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TABLE	I. <u>Elec</u>	trical performance cha	ıracteristics -	Continued.			
	1			Ţ	Lin	Ī	
Test	Symbol 	Condition	ons	Group A subgroups	Min	Max	Unit
Quiescent current	Icc	V _{CC} = 6.0, V _{IN} = V _{CC}	1,2,3		160	μΑ	
Input leakage current	IIN	$V_{CC} = 6.0$, $V_{IN} = V_{CC}$	or GND	1,2,3	 	 ±1 	 μΑ
Functional tests		 See 4.4.1d		7	! !		
Propagation delay, clock	tpHL1,	T _C = +25°C,	V _{CC} = 2.0 V	9	 	225	ns
to carry	tpLH1	CL = 50 pF ±10%	$V_{CC} = 4.5 \text{ V}$	-	j –	43	Ť
<u>3</u> /	 	l See figure 3 	V _{CC} = 6.0 V	<u> </u>	l 	37	<u> </u>
<u>=</u> ,	į	T _C = -55°C, +125°C,	V _{CC} = 2.0 V	10,11		340	ns
		C _L = 50 pF ±10%	V _{CC} = 4.5 V	ή .		65	Ť
	 	 See figure 3	V _{CC} = 6.0 V	<u>-</u>		55	<u> </u>
Propagation delay,	tpHL2,	T _C = +25°C,	V _{CC} = 2.0 V	9		205	l ns
clock to Q	tpLH2	C _L = 50 pF ±10%	V _{CC} = 4.5 V	- †	 	42	Ť
		 See figure 3	$V_{CC} = 6.0 \text{ V}$	-	 	35	†
<u>3</u> /		T _C = -55°C, +125°C,	V _{CC} = 2.0 V	10,11		310	l ns
			V _{CC} = 4.5 V	†		62	Ť
		See figure 3	V _{CC} = 6.0 V	Ī		53 	1

See footnotes at end of table.

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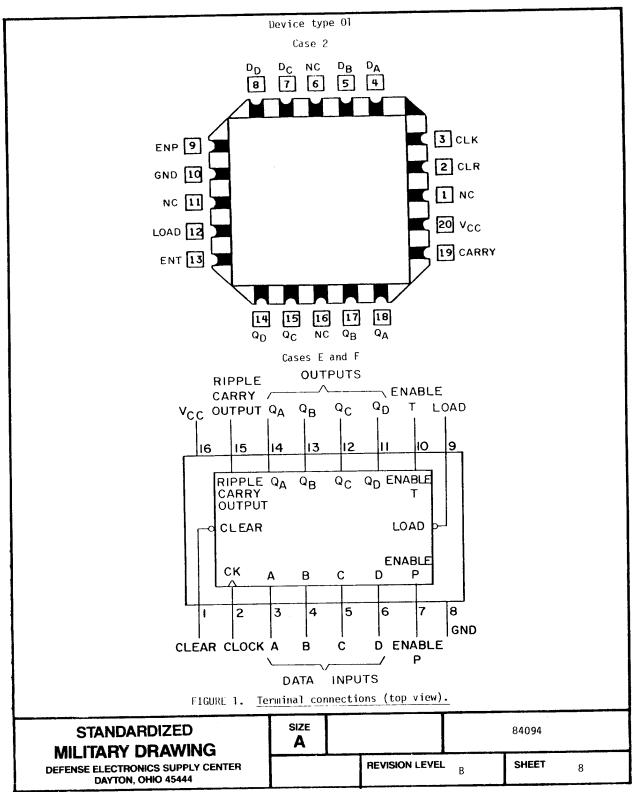
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Test	Symbol	Condition	Group A	Limits		 Unit	
	1	<u> </u>	subgroups	Min Max		 	
Propagation delay,	tpHL3,	T _C = +25°C,	V _{CC} = 2.0 V	9		 195 	l ns
ENT to carry	tPLH3	C _L = 50 pF ±10%	V _{CC} = 4.5 V	† †		39	†
		 See figure 3	V _{CC} = 6.0 V	- † †		33	†
3/	į	$ T_{C} = -55^{\circ}C, +125^{\circ}C,$	V _{CC} = 2.0 V	10,11		295	ns
		C _L = 50 pF ±10%	V _{CC} = 4.5 V	+ †		59	†
	 	See figure 3 	V _{CC} = 6.0 V	-		50	†
Transition time $\frac{4}{}$	t _{TIIL} ,	T _C = +25°C,	V _{CC} = 2.0 V	9		75	ns
	l t _{TLH}	C _L = 50 pF ±10%	V _{CC} = 4.5 V	† 7	l	15	†
	1	 See figure 3	V _{CC} = 6.0 V	-		13	†
		T _C = -55°C, +125°C,	V _{CC} = 2.0 V	10,11		110	ns
		 C _L = 50 pF ±10%	$V_{CC} = 4.5 \text{ V}$	+ -	ļ. — — — — — — — — — — — — — — — — — — —	22	†
		 See figure 3	$\frac{1}{V_{CC}} = 6.0 \text{ V}$	╬ -	<u> </u>	1 19	†

- For a power supply of 5 V ±10%, the worst case output voltages (V_{OH} and V_{OL}) occur for HC at 4.5 V. Thus, the 4.5 V values should be used when designing with this supply. Worst case V_{III} and V_{IL} occur at V_{CC} = 5.5 V and 4.5 V, respectively. (The V_{IH} value at 5.5 V is 3.85 V.) The worst case leakage currents (I_{IN} , I_{CC} , and I_{OZ}) occur for CMOS at the higher voltage and so the 6.0 V values should be used. Power dissipation capacitance (C_{PD}), typically 90 pF, determines the no load dynamic power consumption, $P_{D}=C_{PD}$ $V_{CC}2f+I_{CC}$ V_{CC} , and the no load dynamic current consumption. dynamic current consumption, $I_S=C_{PD}$ V_{CC} f^+I_{CC} .
- $\underline{2}/$ $\,$ V $_{IiI}$ and V $_{IL}$ test not required if applied as forcing function for V $_{OH}$ and V $_{OL}$.
- AC testing at V_{CC} = 2.0 V and V_{CC} = 6.0 V shall be guaranteed, if not tested, to the specified parameters.
- Transition times (t_{THL} , t_{TLH}), if not tested, shall be guaranteed to the specified parameters.

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Device type 01

CLK	CLR	ENP	LNT	Load	Function
† X X X † †	L. 11 11 11 11	X II 1. 1. X	X I. II L X	X H H H L	Clear Count and RC disabled Count disabled Count and RC disabled Load Increment Counter

H = high level, L = low level

X = don't care + = low to high transition

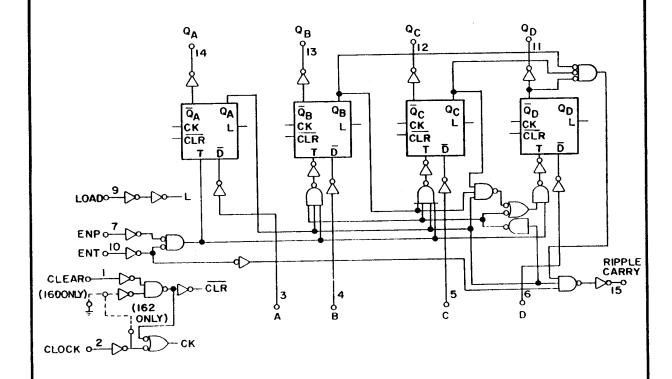
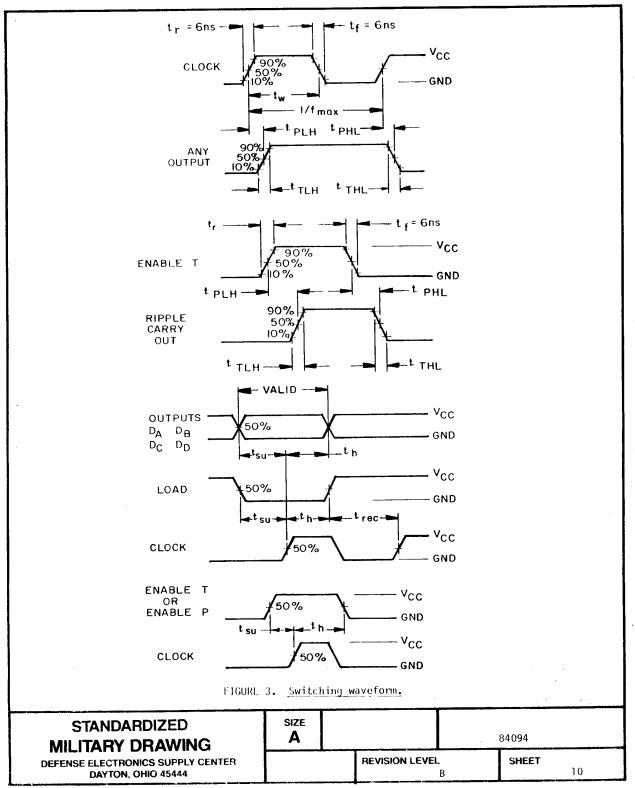


FIGURE 2. Truth table and logic diagram.

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- 3.4 Marking. Marking shall be in accordance with MIL-STD-883 (see 3.1 herein). The part shall be marked with the part number listed in 1.2 herein. In addition, the manufacturer's part number may also be marked as listed in 6.4 herein.
- 3.5 Certificate of compliance. A certificate of compliance shall be required from a manufacturer in order to be listed as an approved source of supply in 6.4. The certificate of compliance submitted to DESC-ECS prior to listing as an approved source of supply shall state that the manufacturer's product meets the requirements of MIL-STD-883 (see 3.1 herein) and the requirements herein.
- 3.6 Certificate of conformance. A certificate of conformance as required in MIL-STD-883 (see 3.1 herein) shall be provided with each lot of microcircuits delivered to this drawing.
- 3.7 Notification of change. Notification of change to DESC-ECS shall be required in accordance with MIL-STD-883 (see 3.1 herein).
- 3.8 <u>Verification and review</u>. DESC, DESC's agent, and the acquiring activity retain the option to review the manufacturer's facility and applicable required documentation. Offshore documentation shall be made available onshore at the option of the reviewer.
 - 4. QUALITY ASSURANCE PROVISIONS
- 4.1 Sampling and inspection. Sampling and inspection procedures shall be in accordance with section 4 of MIL-M-38510 to the extent specified in MIL-STD-883 (see 3.1 herein).
- 4.2 Screening. Screening shall be in accordance with method 5004 of MIL-STD-883, and shall be conducted on all devices prior to quality conformance inspection. The following additional criteria shall apply:
 - a. Burn-in test, method 1015 of MIL-STD-883.
 - (1) Test condition A, B, C, or D using the circuit submitted with the certificate of compliance (see $3.5\ \text{herein}$).
 - (2) $T_A = +125$ °C, minimum.
 - b. Interim and final electrical test parameters shall be as specified in table II herein, except interim electrical parameter tests prior to burn-in are optional at the discretion of the manufacturer.
- 4.3 Quality conformance inspection. Quality conformance inspection shall be in accordance with method 5005 of MIL-STD-883 including groups A, B, C, and D inspections. The following additional criteria shall apply.
 - 4.3.1 Group A inspection.
 - a. Tests shall be as specified in table II herein.
 - b. Subgroups 5, 6, and 8 in table I, method 5005 of MIL-STD-883 shall be omitted.
 - c. Subgroup 4 ($C_{\rm IN}$ measurement) shall be measured only for the initial test and after process or design changes which may affect input capacitance.
 - d. Subgroup 7 test sufficient to verify the truth table.

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TABLE II. Electrical test requirements.

MIL-STD-883 test requirements	Subgroups (per method 5005, table I)
Interim electrical parameters (method 5004)	
Final electrical test parameters (method 5004)	1*, 2, 9
Group A test requirements	
(method 5005)	1, 2, 3, 4, 7, 9, 10, 11**
Groups C and D end-point electrical parameters (method 5005)	1, 2, 3
<u> </u>	1 1

*PDA applies to subgroup 1.

4.3.2 Groups C and D inspections.

- a. End-point electrical parameters shall be as specified in table II herein.
- b. Steady-state life test (method 1005 of MIL-STD-883) conditions:
 - (1) Test condition A, B, C, or D using the circuit submitted with the certificate of compliance (see 3.5 herein).
 - (2) $T_A = +125^{\circ}C$, minimum.
 - (3) Test duration: 1,000 hours, except as permitted by appendix B of MIL-M-38510 and method 1005 of MIL-STD-883.

5. PACKAGING

 $5.1\,$ Packaging requirements. The requirements for packaging shall be in accordance with MIL-M-38510.

6. NOTES

- 6.1 Intended use. Microcircuits conforming to this drawing are intended for use when military specifications do not exist and qualified military devices that will perform the required function are not available for OEM application. When a military specification exists and the product covered by this drawing has been qualified for listing on QPL-38510, the device specified herein will be inactivated and will not be used for new design. The QPL-38510 product shall be the preferred item for all applications.
 - 6.2 Replaceability. Replaceability is determined as follows:
 - a. Microcircuits covered by this drawing will replace the same generic device covered by a contractor-prepared specification or drawing.
 - b. When a QPL source is established, the part numbered device specified in this drawing will be replaced by the microcircuit identified as part number M38510/66303B--.

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^{**}Subgroups 10 and 11, if not tested, shall be guaranteed to the specified limits in table I.

- 6.3 Comments. Comments on this drawing should be directed to DESC-ECS, Dayton, Ohio 45444, or telephone 513-296-5375.
- 6.4 Approved sources of supply. Approved sources of supply are listed herein. Additional sources will be added as they become available. The vendors listed herein have agreed to this drawing and a certificate of compliance (see 3.5) has been submitted to DESC-ECS.

T	Military drawing part number	Vendor CAGE number	Vendor similar part number <u>1</u> /	Replacement military specification part number
+	8409401EX	01295 04713 27014 18714	SNJ54HC162J 54HC162/BEAJC MM54HC162J/883 CD54HC162F/3A	M38510/66303BEX
Ţ	8409401FX	01295	SNJ54HC162W	M38510/66303BFX
+	84094012X	01295 04713 27014	SNJ54HC162FK 54HC162M/B2CJC MM54HC162E/883	M38510/66303B2X

 $\frac{1}{2}$ Caution. Do not use this number for item acquisition. Items acquired to this number may not satisfy the performance requirements of this drawing.

Vendor CAGE number	Vendor name and address
01 295	Texas Instruments, Inc. P.O. Box 6448 Midland, TX 79701
04713	Motorola, Inc. 7402 S. Price Road Tempe, AZ 85283
18714	GE/RCA Corp. Route 202 Somerville, NJ 08876
27014	National Semiconductor 2900 Semiconductor Drive Santa Clara, CA 95051

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